MOSFETs Silicon N-Channel MOS (DTMOSIV)

TK17V65W

1. Applications

- Switching Voltage Regulators

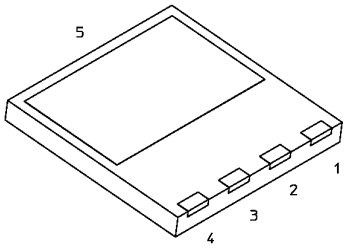
2. Features

(1) Low drain-source on-resistance: $R_{DS(ON)}$ = 0.175 Ω (typ.)
by using Super Junction Structure : DTMOS

(2) Easy to control Gate switching

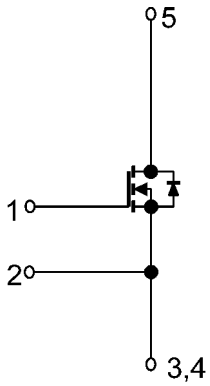
(3) Enhancement mode: V_{th} = 2.5 to 3.5 V (V_{DS} = 10 V, I_D = 0.9 mA)

3. Packaging and Internal Circuit



BOTTOM VIEW

DFN8x8



1: Gate
2: Source1
3,4: Source2
5: Drain (Heatsink)

Notice:
Please use the source1 pin for gate input signal return. Make sure that the main current flows into the source2 pins.

4. Absolute Maximum Ratings (Note) (T_a = 25 °C unless otherwise specified)

Characteristics		Symbol	Rating	Unit
Drain-source voltage		V_{DSS}	650	V
Gate-source voltage		V_{GSS}	±30	
Drain current (DC)	(Note 1)	I_D	17.3	A
Drain current (pulsed)	(Note 1)	I_{DP}	69.2	
Power dissipation	(T_c = 25 °C)	P_D	156	W
Single-pulse avalanche energy	(Note 2)	E_{AS}	210	mJ
Avalanche current		I_{AR}	4.4	A
Reverse drain current (DC)	(Note 1)	I_{DR}	17.3	
Reverse drain current (pulsed)	(Note 1)	I_{DRP}	69.2	
Channel temperature		T_{ch}	150	°C
Storage temperature		T_{stg}	-55 to 150	

Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings.
Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

Start of commercial production
2016-02

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5. Thermal Characteristics

Characteristics	Symbol	Max	Unit
Channel-to-case thermal resistance	$R_{th(ch-c)}$	0.8	°C/W

Note 1: Ensure that the channel temperature does not exceed 150 °C.
Note 2: V_{DD} = 90 V, T_{ch} = 25 °C (initial), L = 19.2 mH, R_G = 25 Ω, I_{AR} = 4.4 A

Note: This transistor is sensitive to electrostatic discharge and should be handled with care.

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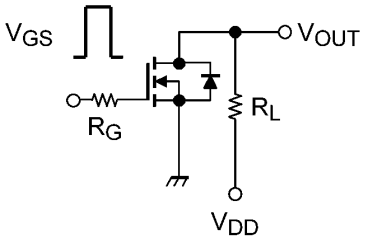
6. Electrical Characteristics

6.1. Static Characteristics (T_a = 25 °C unless otherwise specified)

Characteristics	Symbol	Test Condition	Min	Typ.	Max	Unit
Gate leakage current	I_{GSS}	V_{GS} = ±30 V, V_{DS} = 0 V	—	—	±1	μA
Drain cut-off current	I_{DSS}	V_{DS} = 650 V, V_{GS} = 0 V	—	—	10	
Drain-source breakdown voltage	$V_{(BR)DSS}$	I_D = 10 mA, V_{GS} = 0 V	650	—	—	V
Gate threshold voltage	V_{th}	V_{DS} = 10 V, I_D = 0.9 mA	2.5	—	3.5	
Drain-source on-resistance	$R_{DS(ON)}$	V_{GS} = 10 V, I_D = 8.7 A	—	0.175	0.21	Ω

6.2. Dynamic Characteristics (T_a = 25 °C unless otherwise specified)

Characteristics	Symbol	Test Condition	Min	Typ.	Max	Unit
Input capacitance	C_{iss}	V_{DS} = 300 V, V_{GS} = 0 V, f = 1 MHz	—	1800	—	pF
Reverse transfer capacitance	C_{rss}		—	7	—	
Output capacitance	C_{oss}		—	40	—	
Effective output capacitance	$C_{o(er)}$	V_{DS} = 0 to 400 V, V_{GS} = 0 V	—	65	—	
Gate resistance	r_g	V_{DS} = OPEN , f = 1 MHz	—	1.5	—	Ω
Switching time (rise time)	t_r	See Figure 6.2.1	—	15	—	ns
Switching time (turn-on time)	t_{on}		—	50	—	
Switching time (fall time)	t_f		—	6	—	
Switching time (turn-off time)	t_{off}		—	100	—	
MOSFET dv/dt ruggedness	dv/dt	V_{DD} = 0 to 400 V, I_D = 8.7 A	50	—	—	V/ns



V_{DD} ≈ 400 V
V_{GS} = 10 V/0 V
I_D = 8.7 A
R_L = 45 Ω
R_G = 10 Ω
Duty ≤ 1 %, t_w = 10 μs

Fig. 6.2.1 Switching Time Test Circuit

6.3. Gate Charge Characteristics (T_a = 25 °C unless otherwise specified)

Characteristics	Symbol	Test Condition	Min	Typ.	Max	Unit
Total gate charge (gate-source plus gate-drain)	Q_g	V_{DD} ≈ 400 V, V_{GS} = 10 V, I_D = 17.3 A	—	45	—	nC
Gate-source charge 1	Q_{gs1}		—	11	—	
Gate-drain charge	Q_{gd}		—	20	—	

6.4. Source-Drain Characteristics (T_a = 25 °C unless otherwise specified)

Characteristics	Symbol	Test Condition	Min	Typ.	Max	Unit
Diode forward voltage	V_{DSF}	I_{DR} = 17.3 A, V_{GS} = 0 V	—	—	-1.7	V
Reverse recovery time	t_{rr}	I_{DR} = 8.7 A, V_{GS} = 0 V $-dI_{DR}/dt$ = 50 A/μs	—	300	—	ns
Reverse recovery charge	Q_{rr}		—	2.7	—	μC
Peak reverse recovery current	I_{rr}		—	16	—	A
Diode dv/dt ruggedness	dv/dt	I_{DR} = 8.7 A, V_{GS} = 0 V, V_{DD} = 400 V	15	—	—	V/ns

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7. Marking

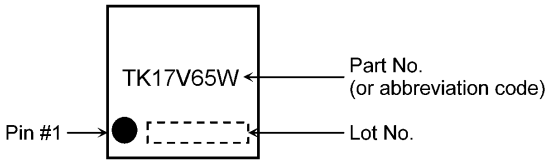


Fig. 7.1 Marking

8. Characteristics Curves (Note)

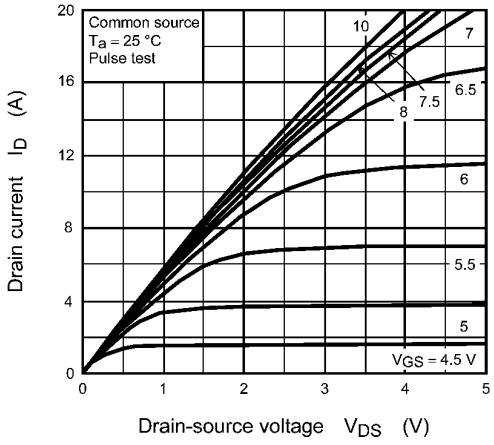


Fig. 8.1 I_D - V_{DS}

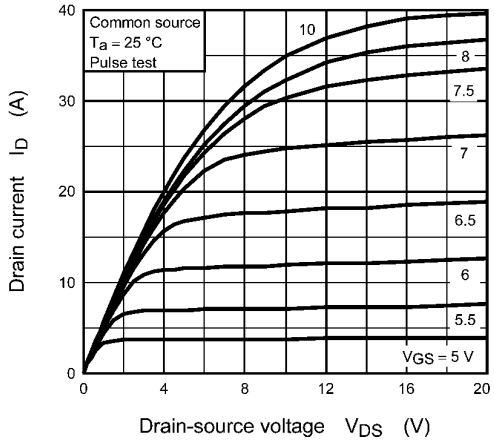


Fig. 8.2 I_D - V_{DS}

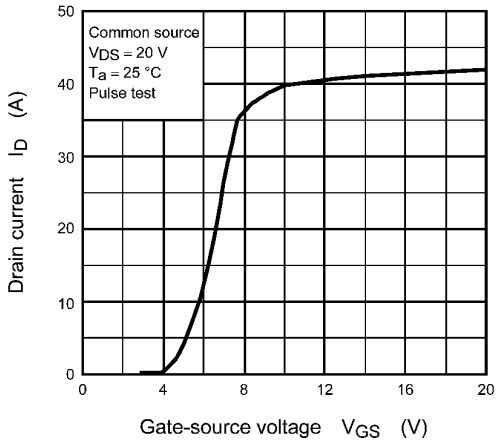


Fig. 8.3 I_D - V_{GS}

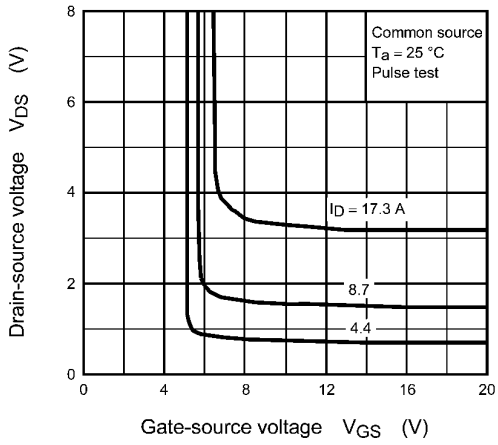


Fig. 8.4 V_{DS} - V_{GS}

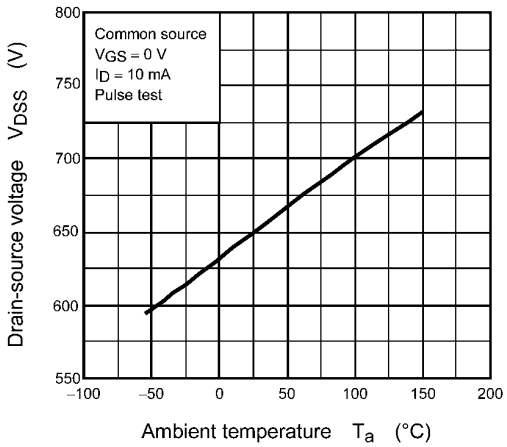


Fig. 8.5 V_{DSS} - T_a

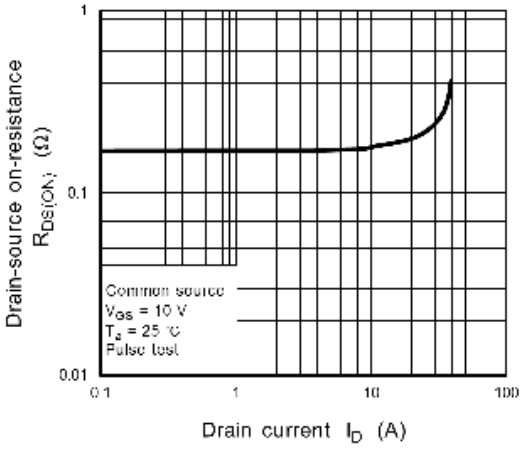


Fig. 8.6 $R_{DS(ON)}$ - I_D

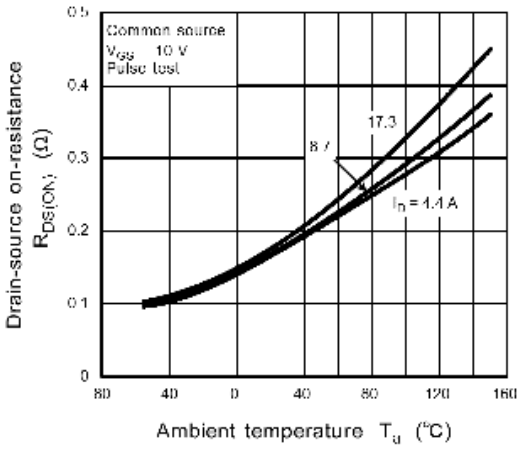


Fig. 8.7 $R_{DS(ON)}$ - T_a

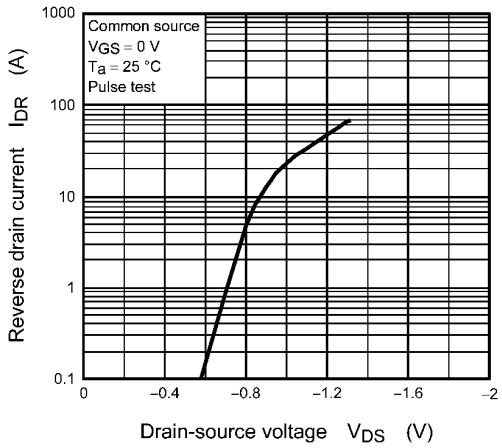


Fig. 8.8 I_{DR} - V_{DS}

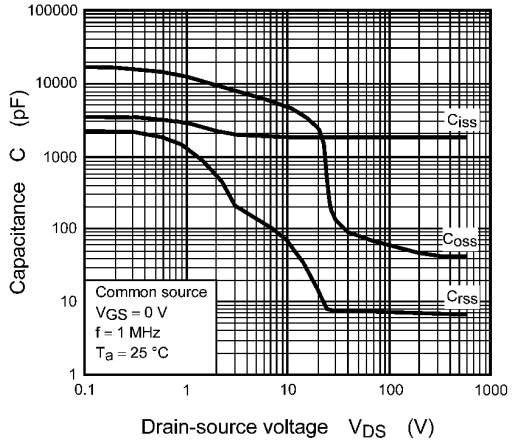


Fig. 8.9 C - V_{DS}

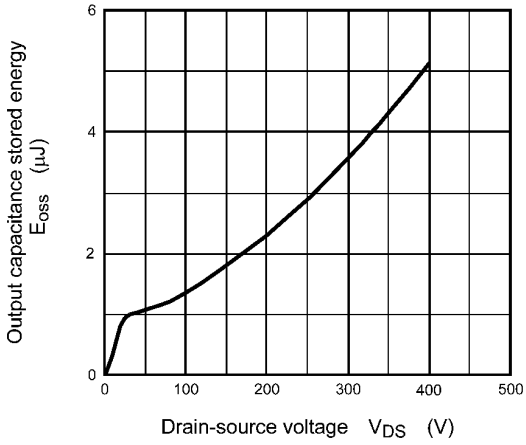


Fig. 8.10 E_{oss} - V_{DS}

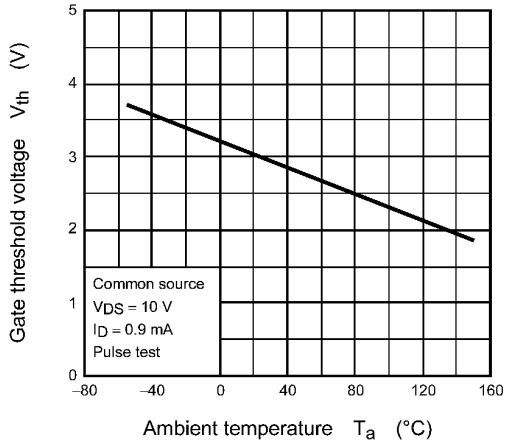


Fig. 8.11 V_{th} - T_a

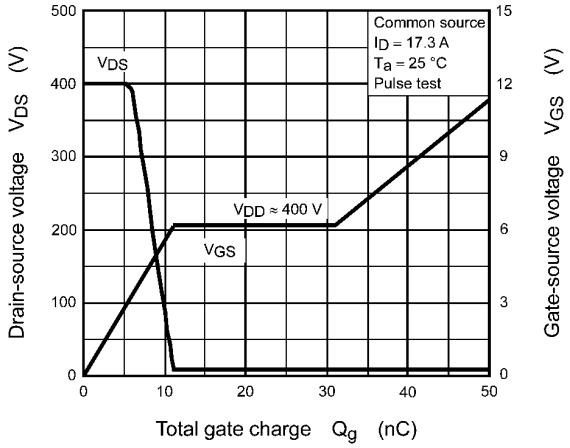


Fig. 8.12 Dynamic Input/Output Characteristics

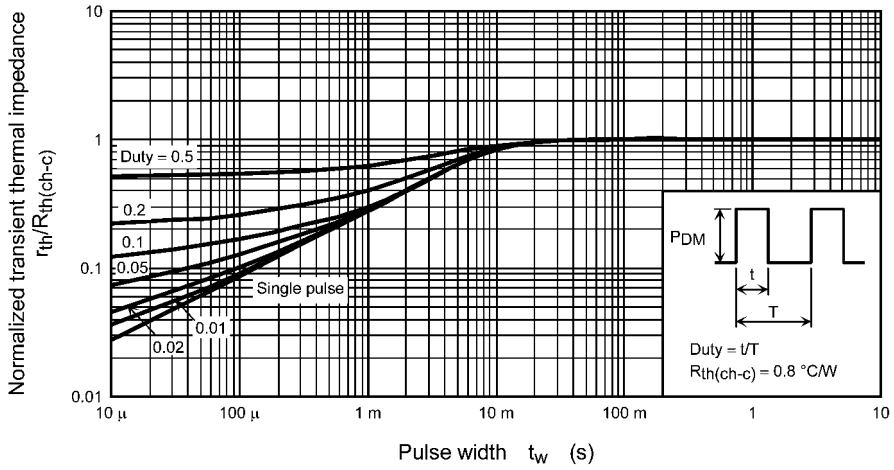


Fig. 8.13 r_{th} - t_w
(Guaranteed Maximum)

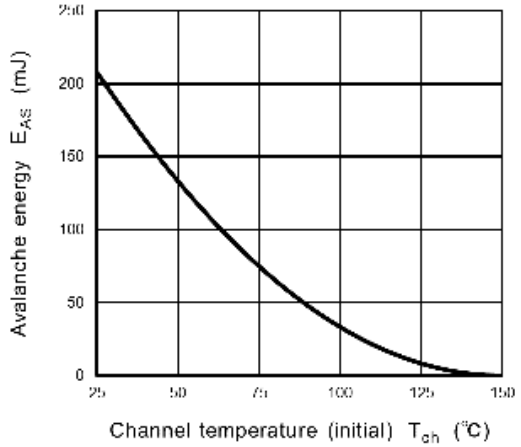


Fig. 8.14 E_{AS} - T_{ch}
(Guaranteed Maximum)

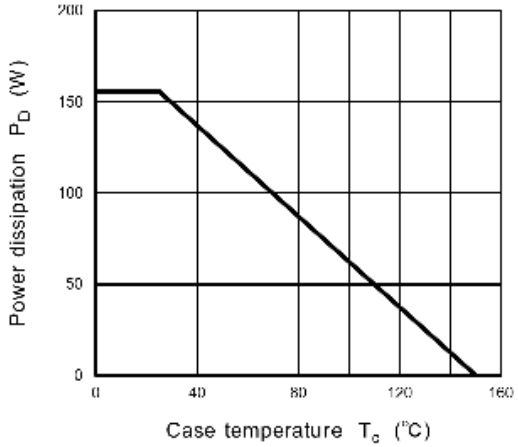
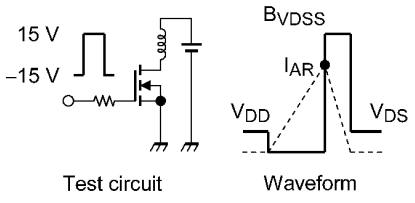


Fig. 8.15 P_D - T_c
(Guaranteed Maximum)



$R_G = 25\ \Omega$, $V_{DD} = 90$ V $E_{AS} = \frac{1}{2} \cdot L \cdot I_{AR}^2 \cdot \left(\frac{B_{VDSS}}{B_{VDSS} - V_{DD}} \right)$

Fig. 8.16 Test Circuit/Waveform

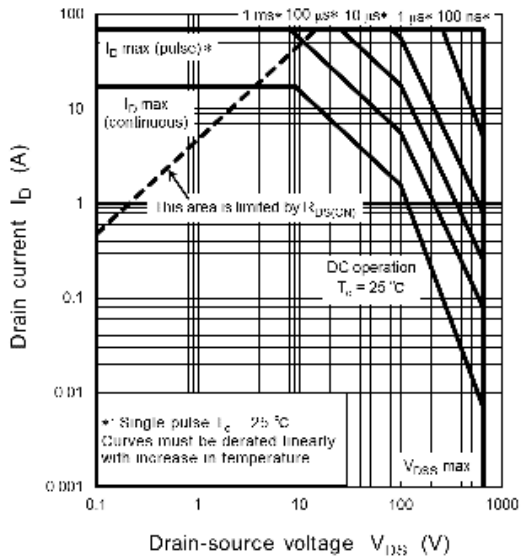
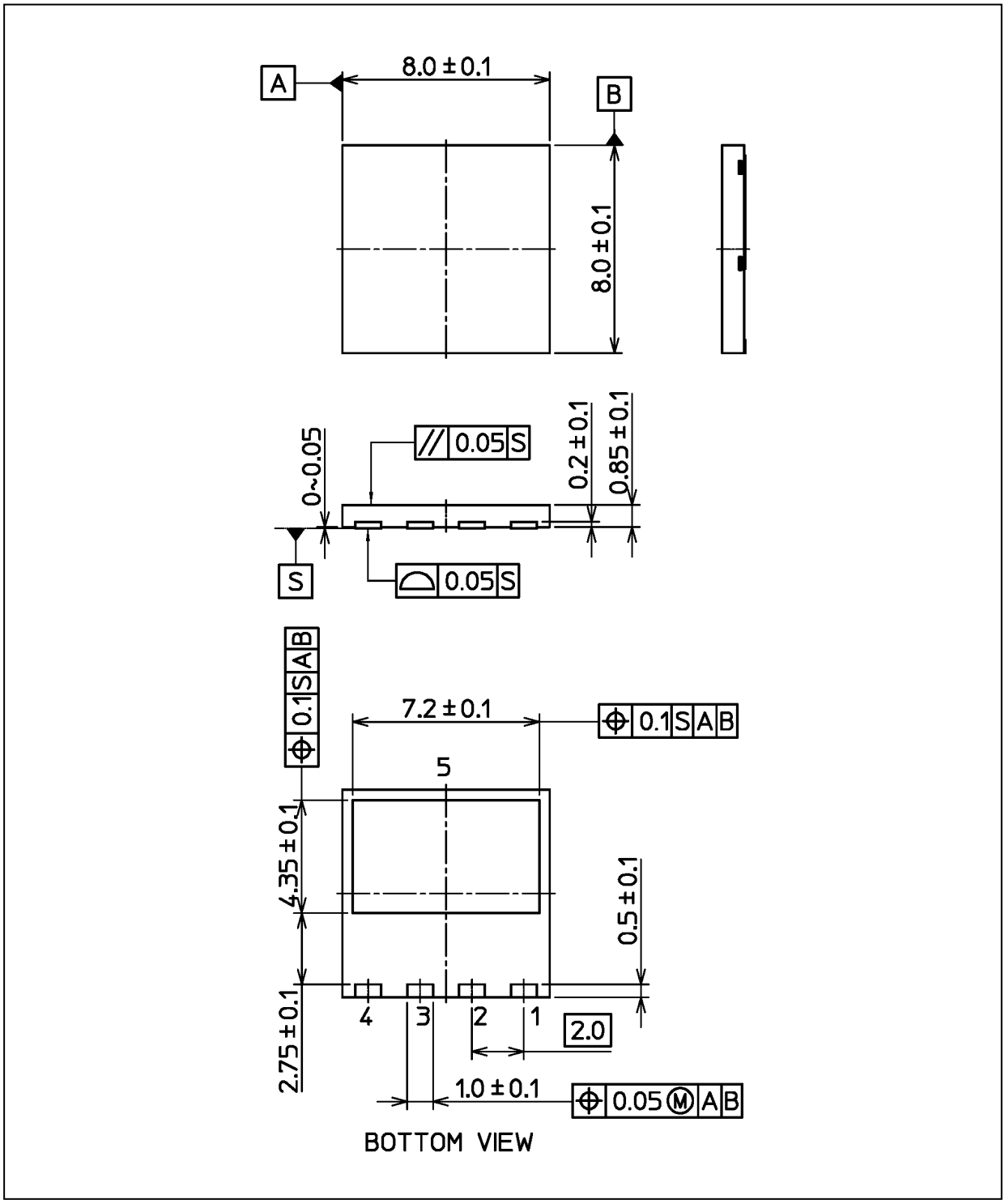


Fig. 8.17 Safe Operating Area (Guaranteed Maximum)

Note: The above characteristics curves are presented for reference only and not guaranteed by production test, unless otherwise noted.

Package Dimensions

Unit: mm



Weight: 0.175 g (typ.)

Package Name(s)
TOSHIBA: 2-8T1A
Nickname: DFN8x8

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